



IEEE Standard for Performance and Test Requirements for Instrument Transformers of a Nominal System Voltage of 115 kV and Above

Power & Energy Society

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Transformers Committee

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IEEE Standard for Performance and Test Requirements for Instrument Transformers of a Nominal System Voltage of 115 kV and Above

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**Transformers Committee
of the
IEEE Power & Energy Society**

Approved 11 September 2009

IEEE-SA Standards Board

Abstract: Single-phase instrument transformers of a nominal system voltage of 115 kV and above with capacitive insulation system for line-to-ground connection and for both indoor and outdoor application is discussed in this standard. This standard is intended for use as a supplement to IEEE Std C57.13™-2008 and as a basis for performance and safety of equipment. It also describes test sequences, criteria, methods, and documentation for the test.

Keywords: design test, high-voltage, instrument transformers, routine tests, special tests, test criteria, test method, test requirements, test sequence

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Introduction

This introduction is not part of IEEE Std C57.13.5-2009, IEEE Standard for Performance and Test Requirements for Instrument Transformers of a Nominal System Voltage of 115 kV and Above.

The mission of the IEEE PC57.13.5 Working Group is to develop a comprehensive set of performance and test requirements for instrument transformers of a nominal system voltage of 115 kV and above. The objective is to improve the performance and safety of the instrument transformers in response to the concern indicated in the publication EPRI Workshop on Failed High Voltage Instrument Transformers, held in September 1990.

The first edition was published in 2003.

The main changes introduced in this revision are:

- Update of references
- Addition of temperature rise limits of terminals
- Additional requirements concerning the use of non-corrosive oil
- Revision of mechanical requirements
- Addition of a new annex related to current transformers used for the detection of unbalance current of capacitor banks
- Addition of a new annex related to current transformers having transient performance requirements
- Addition of a new informative annex giving additional information regarding the Electrical endurance test

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Contents

1. Overview	1
1.1 Scope	1
1.1 Purpose	1
2. Normative references	2
3. Definitions	2
4. General	2
4.1 Insulation requirements	3
4.2 Mineral oil requirements	8
4.3 Requirements for accuracy and accuracy calibration systems	8
4.4 Mechanical performance requirements	9
4.5 Thermal performance requirements	11
4.6 Ground shield requirements	11
4.7 Dissolved gas and water content requirements for new oil-immersed transformers	11
4.8 Endurance capability for fast high voltage transient	12
4.9 Performance of internal arc protection	12
4.10 Identification of test sample in the type test report	12
4.11 Secondary short-circuit capability for voltage transformers	12
5. Test conditions	12
6. Classification of test	13
6.1 Routine tests and test sequences	13
6.2 Type tests and test sequences	16
6.3 Special tests	19
7. Routine test procedures (applicable to instrument transformers)	19
7.1 Verification of terminal markings and polarity	19
7.2 Capacitance and dissipation factor test	19
7.3 Applied voltage test on secondary windings	20
7.4 Insulation resistance test on windings	20
7.5 Lightning impulse voltage test on the primary winding	20
7.6 Power frequency voltage withstand test	21
7.7 Partial discharge test	21
7.8 Dissolved gas and water content analysis for oil-immersed transformers (of a nominal system voltage of 345 kV and above)	22
7.9 Sealing test	22
7.10 Ground shield check	23
7.11 Tests on the mineral oil	23
8. Routine test procedures (applicable to current transformers)	23
8.1 In-rush over-voltage test	23
8.2 Accuracy test for the metering rated current transformers	24
8.3 Resistance measurement of relaying rated secondary windings	25
8.4 Performance characteristics of relaying rated current transformers	25
9. Routine test procedures (applicable to voltage transformers)	26
9.1 Applied voltage test on the neutral terminal	26
9.2 Accuracy test	26

9.3 Excitation characteristics with respect to rated voltage factor.....	26
9.4 Resistance measurement of windings.....	27
10. Type test procedures (applicable to instrument transformers).....	27
10.1 Dissolved gas and water content analysis.....	27
10.2 Mechanical test.....	27
10.3 Lightning impulse voltage test on the primary winding.....	28
10.4 Switching impulse voltage test on the primary winding—wet.....	29
10.5 External radio influence voltage (RIV) test.....	29
10.6 Power frequency voltage withstand test—wet.....	30
10.7 Power frequency voltage withstand and partial discharge test—dry.....	30
10.8 Temperature rise test.....	31
10.9 Short-time mechanical and thermal rating test.....	32
10.10 Accuracy performance test.....	34
10.11 Creepage distance measurement.....	34
10.12 Sealing system test for gas-filled instrument transformers.....	35
11. Type test procedure (applicable to current transformers).....	35
11.1 Secondary open-circuit voltage withstand test.....	35
12. Special test procedures.....	36
12.1 Endurance chopped wave test.....	36
12.2 Internal arc test.....	36
12.3 Seismic qualification.....	37
13. Identification of test sample in the type test report.....	38
13.1 Document package related to transformer type.....	38
13.2 Requirements of the document package.....	38
Annex A (normative) Test code.....	40
Annex B (informative) Dielectric test performed at an altitude of 1000 m or less for instrument transformers designed for installation at altitudes greater than 1000 m.....	44
Annex C (informative) Dielectric tests, oil sampling, and other related measurements in the field.....	46
Annex D (informative) Internal arc protection for instrument transformers.....	47
Annex E (normative) Validity of type test reports and guidance for reviewing the design comparison report for the modified design.....	48
Annex F (informative) Rated voltage factor.....	50
Annex G (normative) Current transformers used for the detection of unbalance current of capacitor banks.....	51
Annex H (informative) Current transformers having transient performance requirements.....	67
Annex I (informative) Electrical endurance test, explanatory note.....	68
Annex J (informative) Bibliography.....	69

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1. Overview

1.1 Scope

This standard applies to single-phase instrument transformers of a nominal system voltage of 115 kV and above with capacitive insulation system for line-to-ground connection and for both indoor and outdoor application.

This standard is intended for use as a supplement to IEEE Std C57.13TM-2008¹ and as a basis for performance and safety of equipment. It also describes test sequences, criteria, methods and documentation for the test.

1.1 Purpose

The purpose of this standard is to supplement the IEEE Std C57.13-2008, with specific requirements to single-phase instrument transformers of a nominal system voltage of 115 kV and above, with capacitive insulation system for line-to-ground connection and for both indoor and outdoor applications.

¹ Information on reference can be found in Clause 2.